

1. The first step is to identify the problem or question that needs to be answered. This involves understanding the context and the specific requirements of the task.

2. The second step is to gather relevant information and data. This can involve research, consultation with experts, or collecting data from various sources.

3. The third step is to analyze the information and data collected. This involves identifying patterns, trends, and relationships that can help in understanding the problem.

4. The fourth step is to develop a solution or answer. This involves applying the knowledge and skills gained from the previous steps to create a response that addresses the problem.

5. The fifth step is to evaluate the solution or answer. This involves checking the results against the original problem and ensuring that the solution is valid and effective.

6. The sixth step is to communicate the solution or answer. This involves presenting the findings in a clear and concise manner, using appropriate language and format.

7. The seventh step is to reflect on the process. This involves thinking about what was learned from the experience and how it can be applied to future problems.

8. The eighth step is to seek feedback. This involves asking others for their thoughts and opinions on the solution, which can help in improving the quality of the work.

9. The ninth step is to document the process. This involves keeping a record of the steps taken and the results achieved, which can be useful for future reference.

10. The tenth step is to share the solution or answer. This involves making the results available to others, which can help in spreading knowledge and improving the overall quality of the work.

McDieunel Marc

3661

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

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Search Notes

Application No.

10/059,018

Examiner

McDieunel Marc

Applicant(s)

TOKI, YASUYUKI

Art Unit

3661

SEARCHED

Class	Subclass	Date	Examiner
700	245	04/28/2004	MM
700	251	4/28/2004	MM
700	252	4/28/2004	MM
700	247	4/28/2004	MM
700	249	4/28/2004	MM
700	255	4/28/2004	MM
700	264	4/28/2004	MM
700	167	4/28/2004	MM
700	174	4/28/2004	MM
318	568.1	4/28/2004	MM
318	568.13	4/28/2004	MM
318	568.13	4/28/2004	MM
318	568.14	4/28/2004	MM
318	568.21	4/28/2004	MM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
700	245	4/28/2004	MM
318	568.1	4/28/2004	MM
901	23	4/28/2004	MM

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Palm inventor search note	4/28/2004	MM